

## Description

The DGTD120T40S1PT is produced using advanced Field Stop Trench IGBT Technology, which provides low  $V_{CE(sat)}$ , excellent quality and high switching performance.

## Features

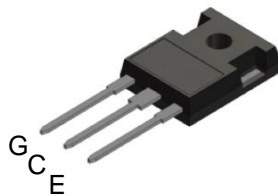
- High-Speed Switching & Low Power Loss
- $V_{CE(sat)} = 2.0V$  @  $I_C = 40A$
- High Input Impedance
- $t_{rr} = 100ns$  (typ) @  $di_F/dt = 200A/\mu s$
- Ultra Soft, Fast Recovery Anti-parallel Diode
- Ultra Narrowed  $V_F$  Distribution Control
- **Lead-Free Finish & RoHS Compliant (Notes 1 & 2)**
- **Halogen and Antimony Free. "Green" Device (Note 3)**
- **For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please [contact us](mailto:contact@diodes.com) or your local Diodes representative. <https://www.diodes.com/quality/product-definitions/>**

## Applications

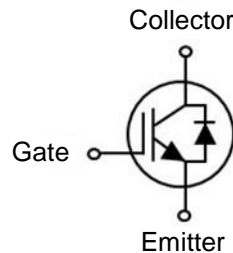
- Motor Drive
- UPS
- Solar Inverter
- IH Cooker

## Mechanical Data

- Case: TO247 (Type MC)
- Case Material: Molded Plastic. "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Terminals: Finish – Matte Tin Plated Leads. Solderable per MIL-STD-202, Method 208 (E3)
- Weight: 5.6 grams (Approximate)



TO247



Device Symbol

## Ordering Information (Note 4)

Part Number	Marking	Quantity
DGTD120T40S1PT	DGTD120T40S1	450 per Box in Tubes (Note 5)

- Notes:
1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
  2. See <https://www.diodes.com/quality/lead-free/> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
  3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
  4. For packaging details, go to our website at <https://www.diodes.com/design/support/packaging/diodes-packaging/>.
  5. 30 Devices per Tube.

## Marking Information



D = Manufacturer's Marking  
 DGTD120T40S1 = Product Type Marking Code  
 YY = Year (ex: 20 = 2020)  
 LLLLL = Lot Code  
 WW = Week (01 to 53)

**Absolute Maximum Ratings** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>CE</sub>	1200	V
DC Collector Current	I <sub>C</sub>	T <sub>C</sub> = +25°C	80
		T <sub>C</sub> = +100°C	40
Pulsed Collector Current, t <sub>p</sub> Limited by T <sub>vjmax</sub>	I <sub>CM</sub>	160	A
Diode Forward Current	I <sub>F</sub>	T <sub>C</sub> = +25°C	80
		T <sub>C</sub> = +100°C	40
Diode Pulsed Current, t <sub>p</sub> Limited by T <sub>vjmax</sub>	I <sub>FM</sub>	160	A
Gate-Emitter Voltage	V <sub>GES</sub>	±20	V
Short Circuit Withstand Time V <sub>CC</sub> ≤ 600V, V <sub>GE</sub> = 15V, T <sub>vj</sub> = +150°C Allowed Number of Short Circuits < 1000 Time Between Short Circuits ≥ 1.0s	t <sub>sc</sub>	10	μs

**Thermal Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)

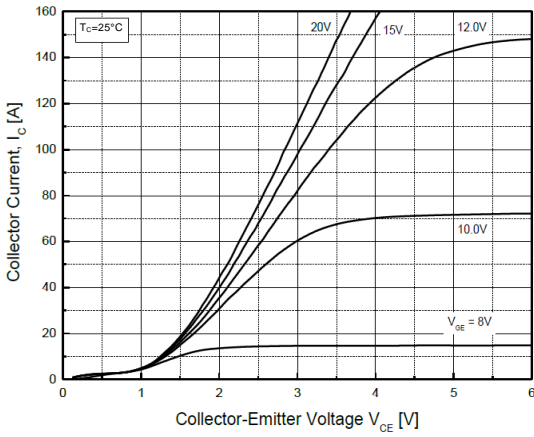
Characteristic	Symbol	Value	Unit
Power Dissipation Linear Derating Factor (Note 6)	P <sub>D</sub>	T <sub>C</sub> = +25°C	357
		T <sub>C</sub> = +100°C	142
Thermal Resistance, Junction to Ambient (Note 6)	R <sub>θJA</sub>	40	°C/W
Thermal Resistance, Junction to Case for IGBT (Note 6)	R <sub>θJC</sub>	0.35	
Thermal Resistance, Junction to Case for Diode (Note 6)	R <sub>θJC</sub>	0.80	
Operating Temperature	T <sub>vj</sub>	-55 to +150	°C
Storage Temperature Range	T <sub>STG</sub>	-55 to +150	

Note: 6. When mounted on a standard JEDEC 2-layer FR-4 board.

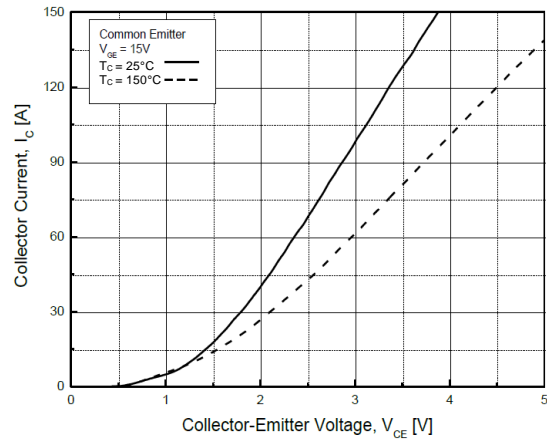
**Electrical Characteristics** (@T<sub>vj</sub> = +25°C, unless otherwise specified.)

Parameter		Symbol	Min	Typ	Max	Unit	Condition
STATIC CHARACTERISTICS							
Collector-Emitter Breakdown Voltage		BV <sub>CES</sub>	1,200	—	—	V	I <sub>C</sub> = 1mA, V <sub>GE</sub> = 0V
Collector-Emitter Saturation Voltage	T <sub>vj</sub> = +25°C	V <sub>CE(sat)</sub>	—	2.00	2.40	V	I <sub>C</sub> = 40A, V <sub>GE</sub> = 15V
	T <sub>vj</sub> = +150°C		—	2.45	—		
Diode Forward Voltage	T <sub>vj</sub> = +25°C	V <sub>F</sub>	—	2.40	3.00	V	I <sub>F</sub> = 40A
	T <sub>vj</sub> = +150°C		—	2.45	—		
Gate-Emitter Threshold Voltage		V <sub>GE(th)</sub>	4.5	5.5	6.5	V	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 1mA
Zero Gate Voltage Collector Current		I <sub>CES</sub>	—	—	1.0	mA	V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V
Gate-Emitter Leakage Current		I <sub>GES</sub>	—	—	±250	nA	V <sub>GE</sub> = 20V, V <sub>CE</sub> = 0V
DYNAMIC CHARACTERISTICS							
Total Gate Charge		Q <sub>g</sub>	—	341	—	nC	V <sub>CE</sub> = 600V, I <sub>C</sub> = 40A, V <sub>GE</sub> = 15V
Gate-Emitter Charge		Q <sub>ge</sub>	—	52	—		
Gate-Collector Charge		Q <sub>gc</sub>	—	126	—		
Input Capacitance		C <sub>ies</sub>	—	6,030	—	pF	V <sub>CE</sub> = 30V, V <sub>GE</sub> = 0V, f = 1MHz
Reverse Transfer Capacitance		C <sub>res</sub>	—	107	—		
Output Capacitance		C <sub>oes</sub>	—	206	—		
SWITCHING CHARACTERISTICS							
Turn-on Delay Time		t <sub>d(on)</sub>	—	65	—	ns	V <sub>GE</sub> = 15V, V <sub>CC</sub> = 600V, I <sub>C</sub> = 40A, R <sub>G</sub> = 10Ω, Inductive Load, T <sub>vj</sub> = +25°C
Rise Time		t <sub>r</sub>	—	55	—		
Turn-off Delay Time		t <sub>d(off)</sub>	—	308	—		
Fall Time		t <sub>f</sub>	—	40	—		
Turn-on Switching Energy		E <sub>on</sub>	—	1.96	—	mJ	
Turn-off Switching Energy		E <sub>off</sub>	—	0.54	—		
Total Switching Energy		E <sub>ts</sub>	—	2.50	—		
Reverse Recovery Time		t <sub>rr</sub>	—	100	—	ns	I <sub>F</sub> = 40A,
Reverse Recovery Current		I <sub>rr</sub>	—	7	—	A	di <sub>F</sub> /dt = 200A/μs,
Reverse Recovery Charge		Q <sub>rr</sub>	—	350	—	nC	T <sub>vj</sub> = +25°C
Turn-on Delay Time		t <sub>d(on)</sub>	—	70	—	ns	V <sub>GE</sub> = 15V, V <sub>CC</sub> = 600V, I <sub>C</sub> = 40A, R <sub>G</sub> = 10Ω, Inductive Load, T <sub>vj</sub> = +150°C
Rise Time		t <sub>r</sub>	—	62	—		
Turn-off Delay Time		t <sub>d(off)</sub>	—	325	—		
Fall Time		t <sub>f</sub>	—	62	—		
Turn-on Switching Energy		E <sub>on</sub>	—	2.35	—	mJ	
Turn-off Switching Energy		E <sub>off</sub>	—	1.61	—		
Total Switching Energy		E <sub>ts</sub>	—	3.96	—		
Reverse Recovery Time		t <sub>rr</sub>	—	180	—	ns	I <sub>F</sub> = 40A,
Reverse Recovery Current		I <sub>rr</sub>	—	10	—	A	di <sub>F</sub> /dt = 200A/μs,
Reverse Recovery Charge		Q <sub>rr</sub>	—	900	—	nC	T <sub>vj</sub> = +150°C

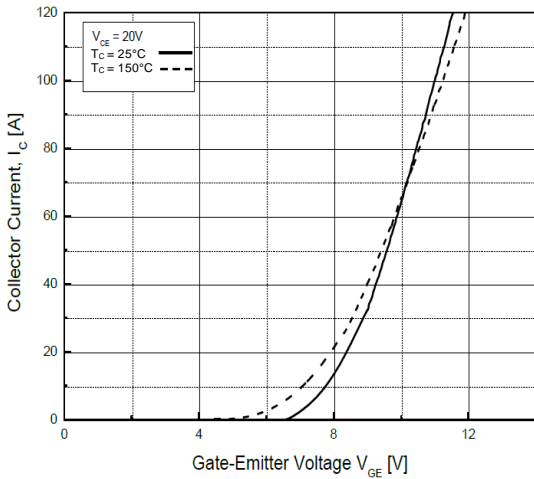
**Typical Performance Characteristics** (@T<sub>A</sub> = +25°C, unless otherwise specified.)



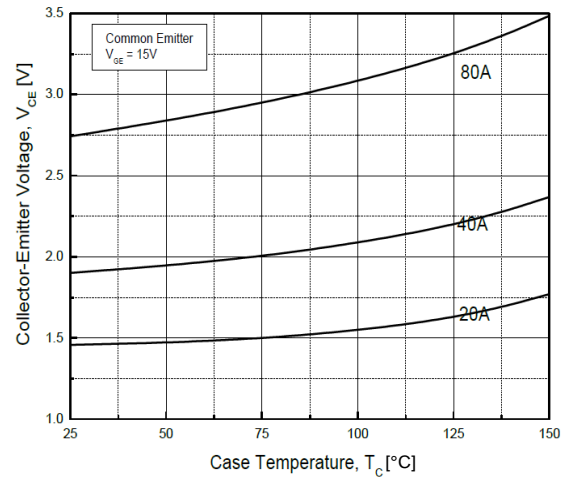
**Fig.1 Typical Output Characteristics**



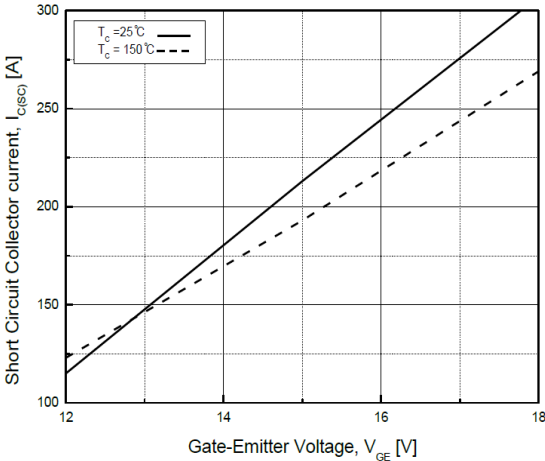
**Fig.2 Typical Collector-Emitter Saturation Voltage**



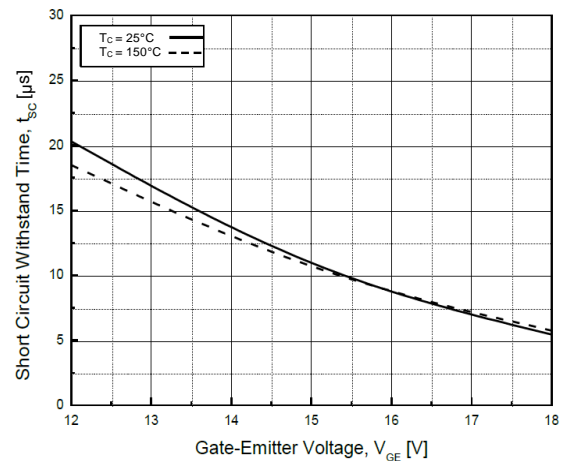
**Fig.3 Typical Transfer Characteristics**



**Fig.4 Typical Collector-Emitter Saturation Voltage at Case Temperature**



**Fig.5 Typical Short Circuit Collector Current**



**Fig.6 Typical Short Circuit Withstand Time**

# Typical Performance Characteristics (continued)

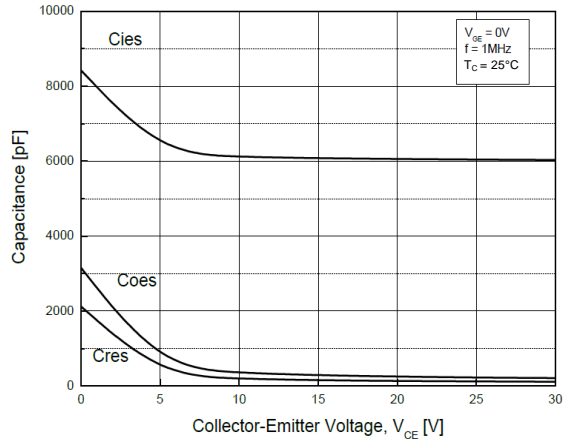


Fig.7 Typical Capacitance

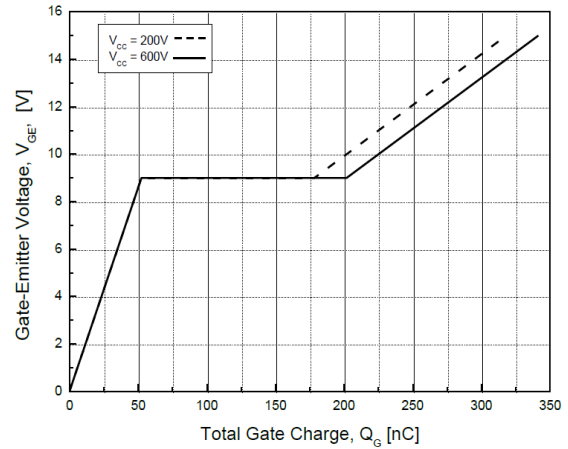


Fig.8 Typical Gate Charge

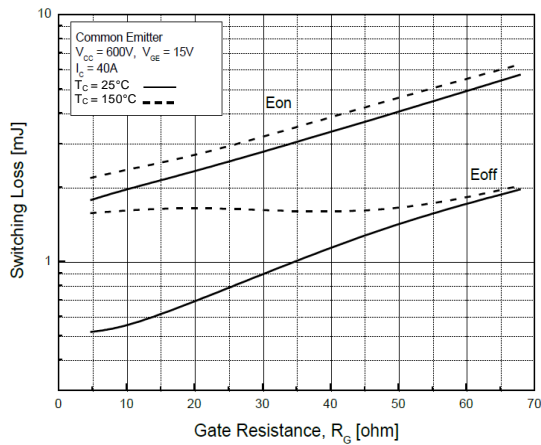


Fig.9 Switching Loss-Gate Resistance

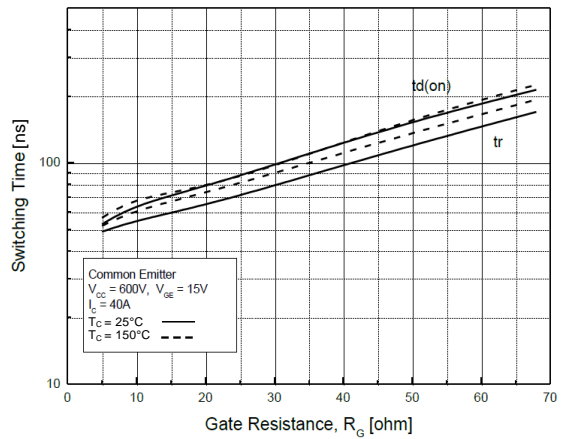


Fig.10 Turn on Characteristics-Gate Resistance

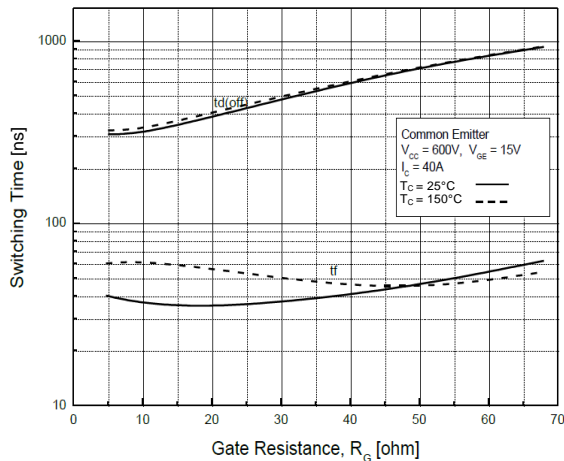


Fig.11 Turn off Characteristics-Gate Resistance

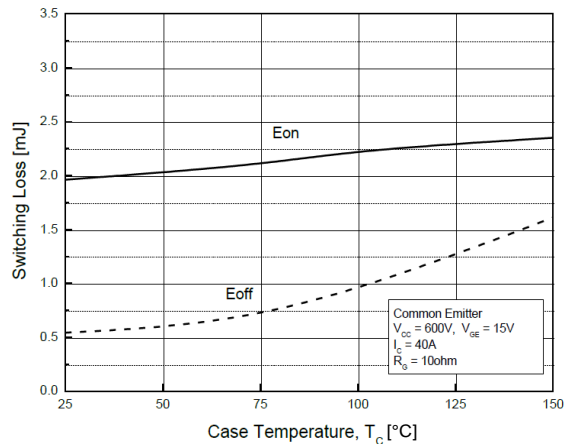
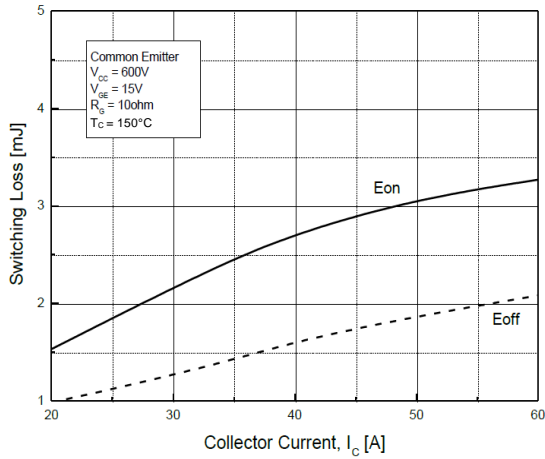
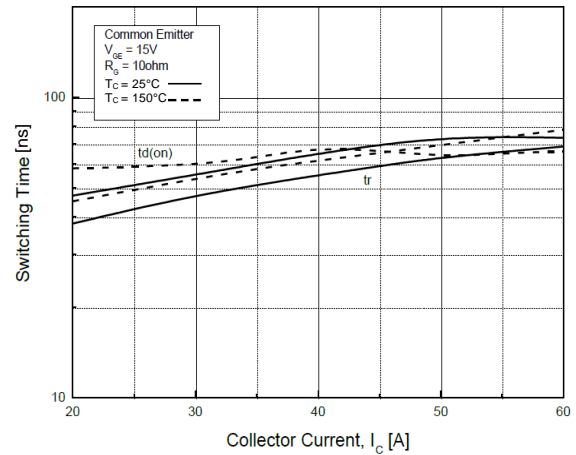


Fig.12 Switching Loss-Case Temperature

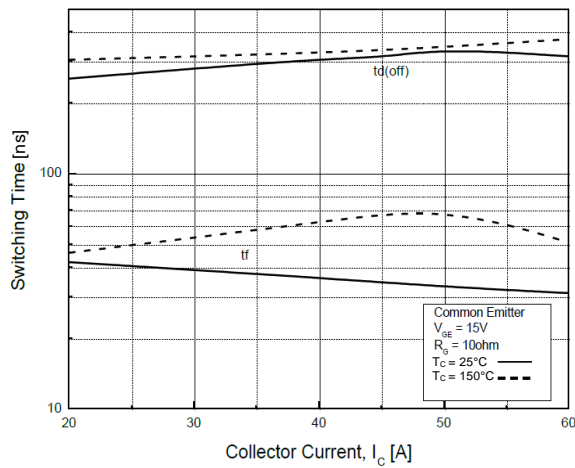
**Typical Performance Characteristics** (continued)



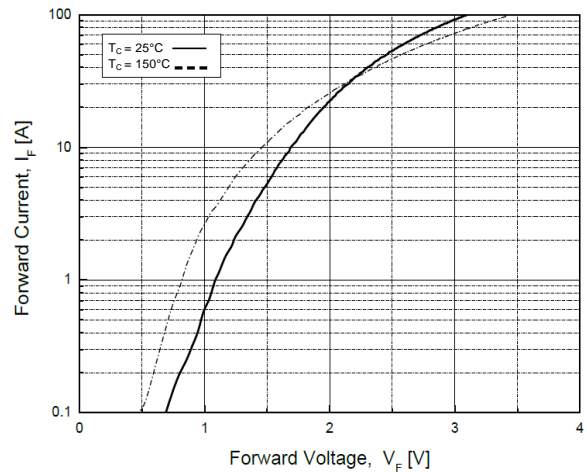
**Fig.13 Switching Loss-Collector Current**



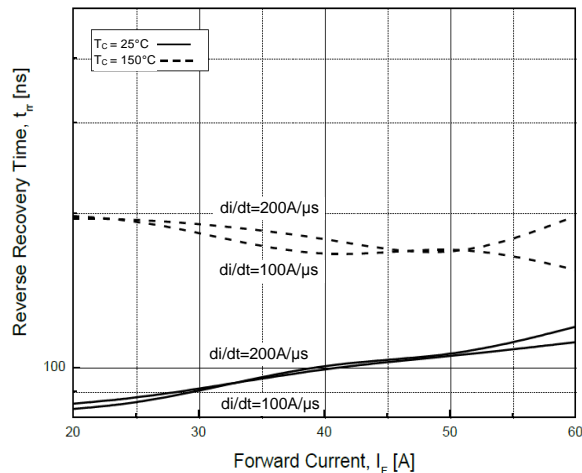
**Fig.14 Typical Turn on-Collector Current**



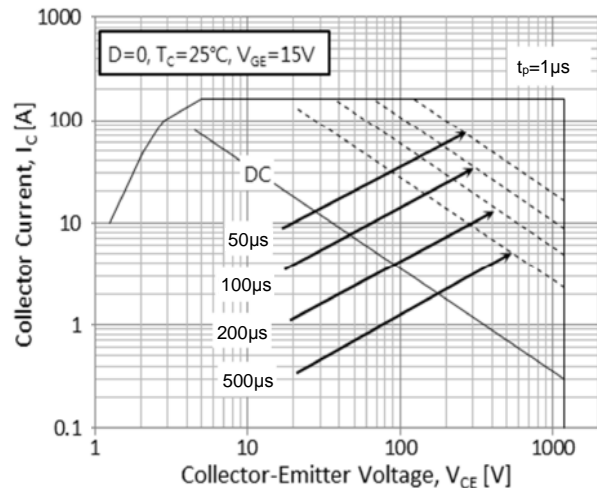
**Fig.15 Typical Turn off-Collector Current**



**Fig.16 Diode Forward Characteristics**



**Fig.17 Typical Turn off-Collector Current**



**Fig.18 Forward Bias Safe Operating Area**

## Typical Performance Characteristics (continued)

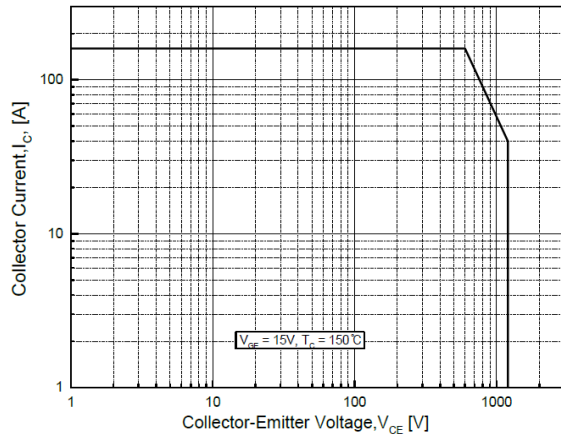


Fig.19 Reverse Bias Safe Operating Area

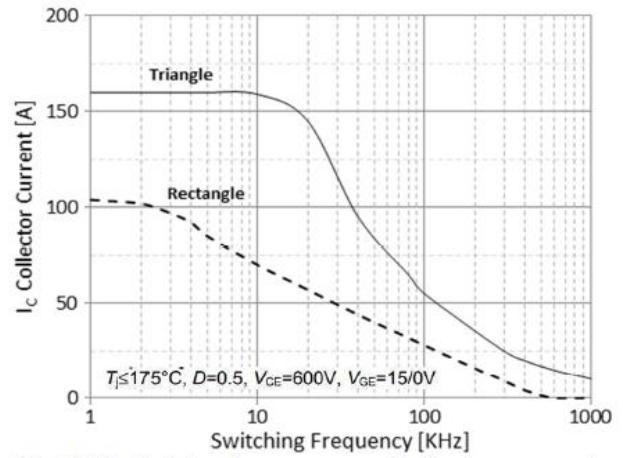


Fig.20 Switching frequency – Collector current

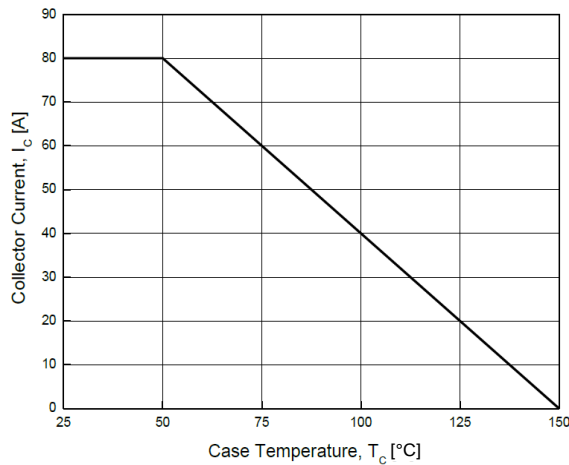


Fig.21 Case Temperature – Collector Current

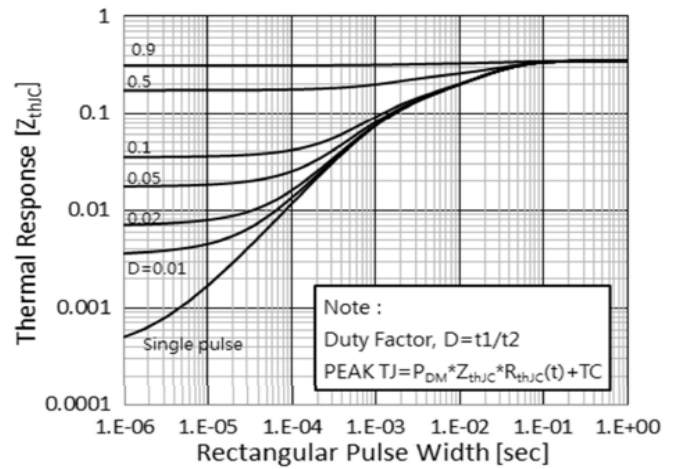
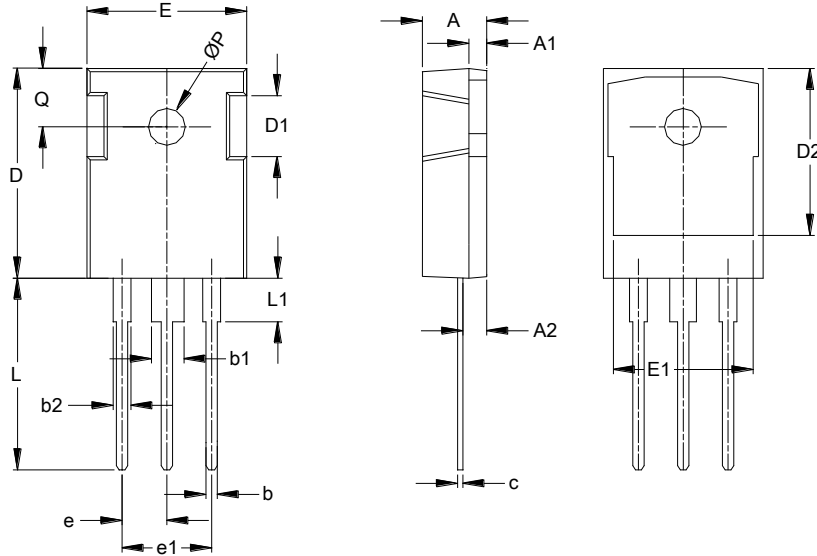


Fig.22 IGBT Transient Thermal Impedance

## Package Outline Dimensions

Please see <http://www.diodes.com/package-outlines.html> for the latest version.

### TO247 (Type MC)



TO247 (Type MC)			
Dim	Min	Max	Typ
A	4.700	5.310	-
A1	1.500	2.490	-
A2	2.200	2.600	-
b	0.990	1.400	-
b1	2.590	3.430	-
b2	1.650	2.390	-
c	0.380	0.890	-
D	20.30	21.46	-
D1	4.320	5.490	-
D2	13.08	-	-
E	15.45	16.26	-
E1	13.06	14.02	-
e	5.450		
e1	10.90		
L	19.81	20.57	-
L1	-	4.500	-
Q	5.380	6.200	-
ØP	3.500	3.700	-
All Dimensions in mm			

Note : For high voltage applications, the appropriate industry sector guidelines should be considered with regards to creepage and clearance distances between device Terminals and PCB tracking.



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